

Notice of References Cited	Application/Control No. 09/683,002	Applicant(s)/Patent Under Reexamination BASTIAENS ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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May 03, 2004

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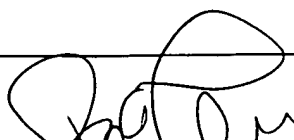
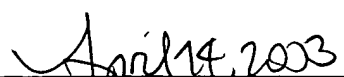
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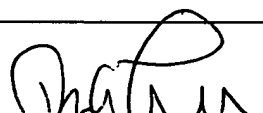
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